

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,326	WEINL ET AL.	
Examiner	Art Unit	
John P. Sheehan	1742	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
PG Pub	Search	8/2/2007	JPS		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	5/30/2006	JS	
PALM Inventor Name Search	5/30/2006	JS	
EAST Update	8/2/2007	JPS	